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Substitute for form 1449A/PTO						14	Application Number	Filed Herewith 10/676,695			
]	Filing Date	9/30/2003			
INFORMATION DISCLOSURE STATEMENT BY APPLICANT							First Named Inventor:	Fu-Chieh Hsu			
(use as many sheets as necessary)							Examiner name: A. Wilson (Parent case)	GROUP: 2815 (Parent case)			
Sheet	1 of 1				1		Attorney Docket Number	MST-013-1D			
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^{*}EXAMINER: Initial if reference considered, whether or not citation considered. Include copy of this form with next communication to applicant.

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